

General Description

The WST3052 is the highest performance trench N-Ch MOSFET with extreme high cell density , which provide excellent R_{DSON} and gate charge for most of the small power switching and load switch applications.

The WST3052 meet the RoHS and Green Product requirement with full function reliability approved.

Features

- Advanced high cell density Trench technology
- Super Low Gate Charge
- Excellent Cdv/dt effect decline
- Green Device Available

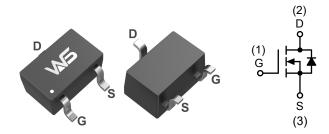
Product Summery

BV _{DSS}	R _{DSON}	I _D
30V	50mΩ	2.5A

Applications

 Power Management in Notebook Computer Portable Equipment and Battery Powered Systems.

SOT-323-3L Pin Configuration



Absolute Maximum Ratings

Symbol	Parameter	Rating	Units
V_{DS}	Drain-Source Voltage	30	V
V_{GS}	Gate-Source Voltage	±12	V
I _D @T _c =25℃	Continuous Drain Current, V _{GS} @ 10V ¹	2.5	А
I _D @T _c =70°C	Continuous Drain Current, V _{GS} @ 10V ¹	2.0	А
I _{DM}	Pulsed Drain Current ²	13	Α
P _D @T _A =25℃	Total Power Dissipation ³	0.7	W
P _D @T _A =70°C	Total Power Dissipation ³	0.45	W
T _{STG}	Storage Temperature Range -55 to 150		$^{\circ}$
TJ	Operating Junction Temperature Range -55 to 150		

Thermal Data

Symbol	Parameter	Тур.	Max.	Unit
$R_{\theta JA}$	Thermal Resistance Junction-ambient ¹		180	°C/W
$R_{ heta JA}$	Thermal Resistance Junction-Ambient ¹ (t ≤10s)			°C/W
$R_{ heta JC}$	Thermal Resistance Junction-Case ¹		100	°C/W



Electrical Characteristics (T_J=25 ℃, unless otherwise noted)

Symbol	Parameter	Conditions	Min.	Тур.	Max.	Unit	
BV _{DSS}	Drain-Source Breakdown Voltage	V _{GS} =0V , I _D =250uA	30			V	
$\triangle BV_{DSS}/\triangle T_{J}$	BVDSS Temperature Coefficient	Reference to 25℃, I _D =1mA		0.025		V/℃	
D	Static Drain-Source On-Resistance ²	V _{GS} =4.5V , I _D =2.5A		50	60	C	
R _{DS(ON)}	Static Drain-Source On-Resistance	V _{GS} =2.5V , I _D =2A		60	70	mΩ	
V _{GS(th)}	Gate Threshold Voltage	\/ -\/ -250A	0.5	0.7	1.0	V	
$\triangle V_{GS(th)}$	V _{GS(th)} Temperature Coefficient	$V_{GS}=V_{DS}$, $I_D=250uA$		-4.8		mV/℃	
	Dunin Course Legland Cumant	V _{DS} =24V , V _{GS} =0V , T _J =25°C			1		
I _{DSS}	Drain-Source Leakage Current	V _{DS} =24V , V _{GS} =0V , T _J =55°C			30	uA	
I _{GSS}	Gate-Source Leakage Current	V_{GS} = $\pm 20V$, V_{DS} = $0V$			±100	nA	
gfs	Forward Transconductance	V _{DS} =5V , I _D =2A		7		S	
R_g	Gate Resistance	V _{DS} =0V , V _{GS} =0V , f=1MHz		2.5	5	Ω	
Q_{g}	Total Gate Charge (4.5V)			4.0	8.4		
Q_gs	Gate-Source Charge	V_{DS} =10V , V_{GS} =4.5V , I_{D} =1A		0.3	3.5	nC	
Q_gd	Gate-Drain Charge			1.5	2.9		
T _{d(on)}	Turn-On Delay Time			3.5	5.2		
Tr	Rise Time	V_{DD} =10V , V_{GS} =10V , R_G =6 Ω ,		13.3	21		
T _{d(off)}	Turn-Off Delay Time	$I_D=1A$, $R_L=10\Omega$.		2	5	ns	
T _f	Fall Time			13.2	20		
C _{iss}	Input Capacitance			286			
Coss	Output Capacitance	V _{DS} =10V , V _{GS} =0V , f=1MHz		60		pF	
C _{rss}	Reverse Transfer Capacitance			50			

Diode Characteristics

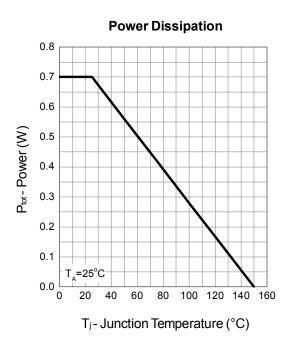
Symbol	Parameter	Conditions	Min.	Тур.	Max.	Unit
I _S	Continuous Source Current ^{1,4}	\\ -\\ -0\\			2.5	Α
I _{SM}	Pulsed Source Current ^{2,4}	V _G =V _D =0V , Force Current			13	Α
V _{SD}	Diode Forward Voltage ²	V _{GS} =0V , I _S =1A , T _J =25℃			1.0	V
t _{rr}	Reverse Recovery Time			15		nS
Q _{rr}	Reverse Recovery Charge	IF=5A , dI/dt=100A/µs , T _J =25℃		3.7		nC

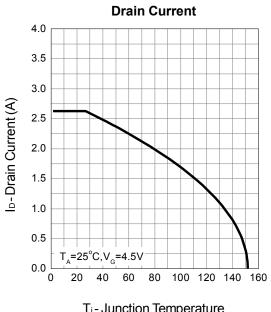
Note

- 1.The data tested by surface mounted on a 1 inch² FR-4 board with 2OZ copper,t<10sec.
- 2.The data tested by pulsed , pulse width $\leq 300 \text{us}$, duty cycle $\leq 2\%$
- 3. The power dissipation is limited by 150 ℃ junction temperature
- 4. The data is theoretically the same as I_D and I_{DM} , in real applications, should be limited by total power dissipation.

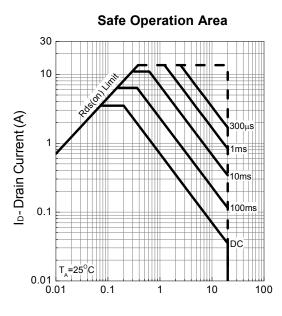
www.winsok.tw Page 2 5 HY - D Q

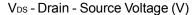


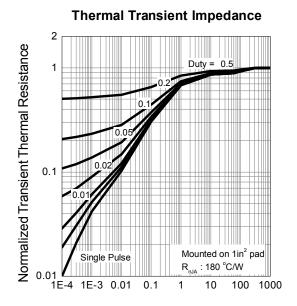




T_j - Junction Temperature

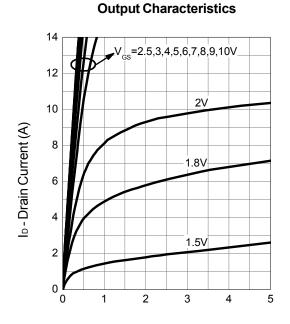






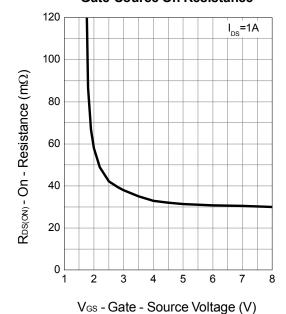
Square Wave Pulse Duration (sec)

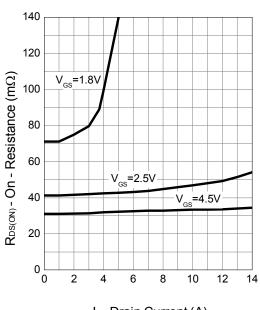




V_{DS}-Drain - Source Voltage (V)

Gate-Source On Resistance

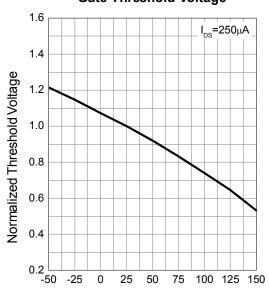




Drain-Source On Resistance

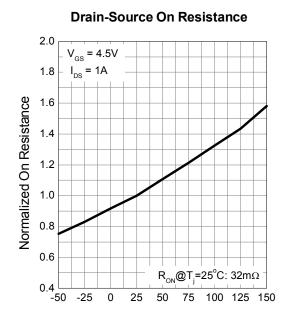
ID-Drain Current (A)

Gate Threshold Voltage



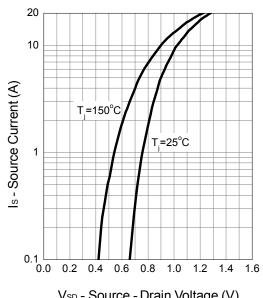
T_j - Junction Temperature (°C)



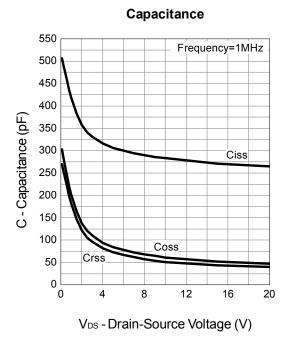


T_j- Junction Temperature (°C)

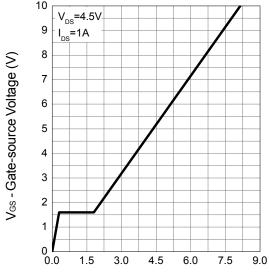
Source-Drain Diode Forward



VsD - Source - Drain Voltage (V)



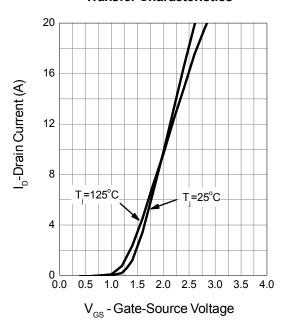




Q_G-Gate Charge (nC)

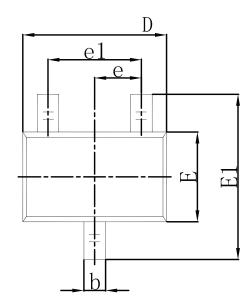


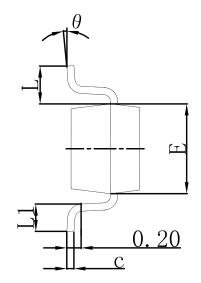
Transfer Characteristics

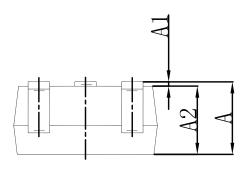




Packaging information







Symbol	Dimensions In Millimeters		Dimensions I	n Inches
Syllibol	Min	Max	Min	Max
А	0.900	1.100	0.035	0.043
A1	0.000	0.100	0.000	0.004
A2	0.900	1.000	0.035	0.039
b	0.200	0.400	0.008	0.016
С	0.080	0.150	0.003	0.006
D	2.000	2.200	0.079	0.087
Е	1.150	1.350	0.045	0.053
E1	2.150	2.450	0.085	0.096
е	0.650 TYP		0.026 TYP	
e1	1.200	1.400	0.047	0.055
L	0.525	0.525 REF 0.021 REF		REF
L1	0.260	0.460	0.010	0.018
θ	0°	8°	0°	8°



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